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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

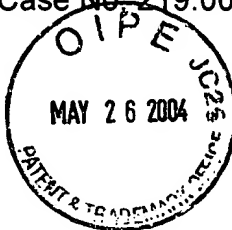
(Case No. 219.003-US)

In the Application of: **Yamada**

Serial No: **09/865,528**

Filed: **May 29, 2001**

Title: **Semiconductor Device Test Method and  
Semiconductor Device Tester**



)  
) Group  
) Art Unit: **2829**  
)  
) Before  
) Examiner: **V. Nguyen**  
)

Commissioner for Patents  
P. O. Box 1450  
Alexandria, VA 22313-1450

**FEE TRANSMITTAL**

Dear Sir:

Transmitted herewith is an **Information Disclosure Statement** (1 page + Form PTO-1449 (1 sheet) and references cited therein.

The fee has been calculated as shown below:

CLAIMS AS AMENDED						
	Claims Remaining	Highest Number Previously Paid	Extra	Rate		Amount
				Large	Small	
Number of Claims In (in excess of 20)	0	0	0	\$18.00	\$9.00	-0-
Independent Claims (in excess of 3)	0	0	0	\$84.00	\$42.00	-0-
Extension Fee: a) One Month				\$110.00	\$55.00	-0-
Filing of Information Disclosure Statement (37 C.F.R. §1.17(p)):						\$180.00
TOTAL FEE DUE:						\$180.00

**Method of Payment:**

☒ [XX] A check payable to the Commissioner of Patents and Trademarks, in the amount of \$180.00 is enclosed as payment of the Total Fee.

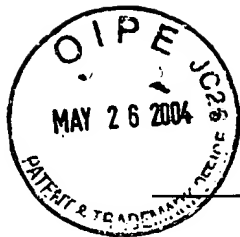
☐ [ ] Please charge my Deposit Acc. 50-0763 in the amount of \$\_\_\_\_\_ to cover the above fees. A duplicate copy of this sheet is enclosed.

☒ [XX] The Commissioner is hereby authorized to charge any fees that may be required, or credit any overpayment to Deposit Acc. 50-0763. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

Neil Steinberg, Reg. No. 34,735  
Telephone No. (650) 968-8079

Date: May 24, 2004



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE  
(219.003-US)

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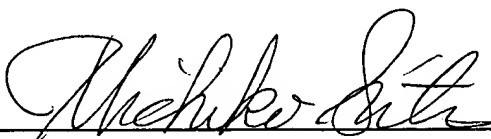
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**Certificate of Mailing under 37 CFR 1.8**

I hereby certify that the attached: **(1)** Information Disclosure Statement (1 page + Modified PTO-1449 (1 sheet) and References cited therein); **(2)** Fee Transmittal (1 page + 1 copy thereof); **(3)** Check (\$180.00) are being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to:

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

on May 24, 2004.

  
\_\_\_\_\_  
Signature

  
\_\_\_\_\_  
Print Name of Person Signing Certificate

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

(Case No. 219.003-US)

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Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

Dear Sir:

Submitted herewith is one (1) sheet of a modified Form PTO-1449. A copy of each document cited on the attached Form PTO-1449 is also submitted.

It is respectfully requested that the Examiner make his/her consideration of these documents formally of record with the initial Office Action.

Respectfully submitted,

A handwritten signature in black ink, appearing to read "Neil A. Steinberg", written over a horizontal line.

Date: May 24, 2004

Neil A. Steinberg  
Reg. No. 34,735  
650-968-8079

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PTO-1449 (Modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  INFORMATION DISCLOSURE STATEMENT BY APPLICANT	ATTY. DOCKET NO. <b>219.003-US</b>	SERIAL NUMBER <b>09/865,528</b>
	APPLICANT(S) <b>Yamada</b>	
	FILING DATE <b>May 29, 2001</b>	GROUP ART UNIT <b>2829</b>

## U.S. PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE
	5,989,919	11/1999	Aoki			
	6,466,315	10/2002	Karpol et al.			

## FOREIGN PATENT DOCUMENTS

EXAMINER INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION YES/NO	

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER	DATE CONSIDERED
EXAMINER: Initial citation if reference was considered. Draw line through citation if not in conformance to MPEP 609 and not considered. Include copy of this form with next communication to applicant.	